

Search Notes

Application No.

10/651,428

Examiner

Yuwen Pan

Applicant(s)

XIE, FEI

Art Unit

2682

SEARCHED

Class	Subclass	Date	Examiner
		9	
455	412.1	9/9/04	YW
	413		
	566		
704	233		
345	727		
	728		
379	85		
	88.1		
	88.07		
	67.1	↓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner